

# GaAs INTEGRATED CIRCUIT $\mu PG2135TK$

# L-BAND PA DRIVER AMPLIFIER

#### DESCRIPTION

The  $\mu$ PG2135TK is GaAs MMIC for PA driver amplifier which were developed for mobile phone and another Lband application.

This device can operate with 3.0 V TYP., having the high gain and low distortion. This device is housed in a 6-pin lead-less minimold package. And this package is able to high-density surface mounting.

#### FEATURES

٠	Operation frequency	: fopt = 1 429 to 1 453 MHz (1 441 MHz TYP.)
•	Supply voltage	: VDD1 = 2.7 to 3.3 V (3.0 V TYP.)
		: VDD2 = 3.0 to 4.2 V (3.5 V TYP.)
•	Circuit current	: IDD = 35 mA TYP. @ VDD1 = $3.0 \text{ V}$ , VDD2 = $3.5 \text{ V}$ , VAGC = $2.5 \text{ V}$ , Pin = $-16 \text{ dBm}$
•	Power gain	: GP = 30 dB TYP. @ Vdd1 = 3.0 V, Vdd2 = 3.5 V, Vagc = 2.5 V, Pin = $-16 \text{ dBm}$
•	Gain control range	: GCR = 42 dB TYP. @ VDD1 = 3.0 V, VDD2 = 3.5 V, VAGC = 0.5 to 2.5 V,
		Pin = -16 dBm
•	Low distortion	: Padj1 = -60 dBc TYP. @ VDD1 = 3.0 V, VDD2 = 3.5 V, VAGC = 2.5 V, Pout = +12 dBm,
		$\Delta f = \pm 50 \text{ kHz}$ , 21 kHz Bandwidth
•	High-density surface mounting	$\cdot$ 6-pin lead-less minimold package (1.5 $\times$ 1.1 $\times$ 0.55 mm)

• High-density surface mounting : 6-pin lead-less minimold package ( $1.5 \times 1.1 \times 0.55$  mm)

#### APPLICATION

• Digital Cellular: PDC 1.5 GHz etc.

#### ORDERING INFORMATION

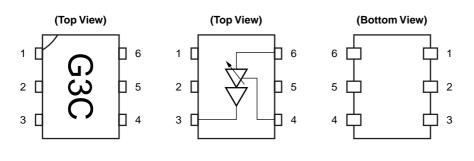
Part Number	Package	Marking	Supplying Form
μPG2135TK-E2	6-pin lead-less minimold (1511)	G3C	<ul> <li>Embossed tape 8 mm wide</li> <li>Pin 1, 6 face the perforation side of the tape</li> <li>Qty 5 kpcs/reel</li> </ul>

**Remark** To order evaluation samples, contact your nearby sales office. Part number for sample order: µPG2135TK

Caution Observe precautions when handling because these devices are sensitive to electrostatic discharge.

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all devices/types available in every country. Please check with local NEC Compound Semiconductor Devices representative for availability and additional information.

#### PIN CONNECTIONS AND INTERNAL BLOCK DIAGRAM



Pin No.	Pin Name	
1	Vdd1	
2	GND	
3	OUTPUT/VDD2	
4	VAGC	
5	GND	
6	INPUT	

## ABSOLUTE MAXIMUM RATINGS (TA = +25°C, unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Supply Voltage 1, 2	VDD1, 2	6.0	V
Gain Control Voltage	VAGC	6.0	V
Input Power	Pin	-8	dBm
Power Dissipation	PD	140 <sup>Note</sup>	mW
Operating Ambient Temperature	TA	-30 to +90	°C
Storage Temperature	Tstg	-35 to +150	°C

Note Mounted on double-sided copper-clad  $50 \times 50 \times 1.6$  mm epoxy glass PWB, T<sub>A</sub> = +85°C

## **RECOMMENDED OPERATING RENGE (TA = +25°C, unless otherwise specified)**

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Operating Frequency	fopt	1 429	1 441	1 453	MHz
Supply Voltage 1	V <sub>DD1</sub>	2.7	3.0	3.3	V
Supply Voltage 2	Vdd2	3.0	3.5	4.2	V
Gain Control Voltage	VAGC	0	-	2.5	V
Input Power	Pin	_	-16	-10	dBm

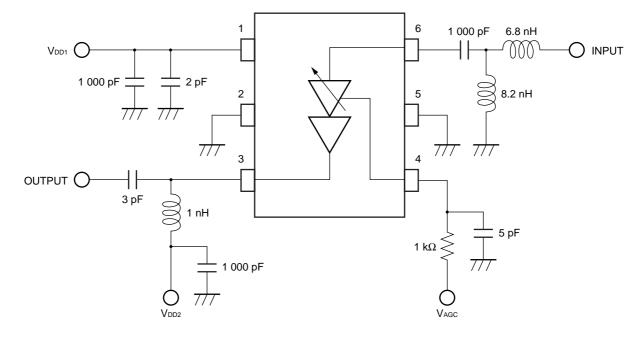
## **ELECTRICAL CHARACTERISTICS**

(TA = +25°C, V<sub>DD1</sub> = 3.0 V, V<sub>DD2</sub> = 3.5 V,  $\pi$ /4DQPSK modulated signal input, with external input and output matching, unless otherwise specified)

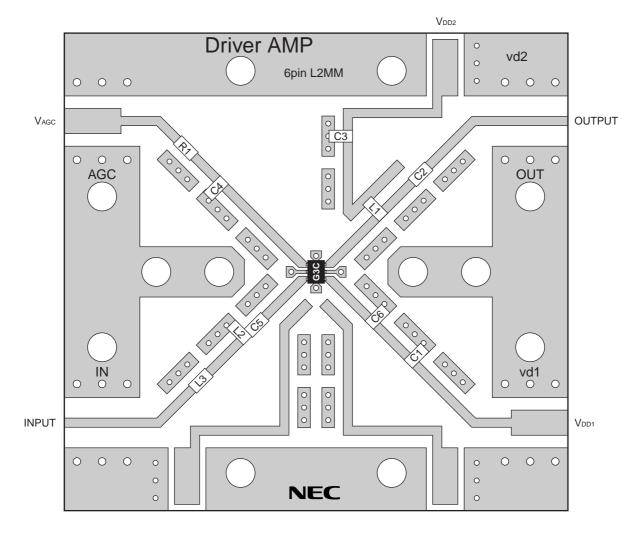
Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Operating Frequency	fopt		1 429	1 441	1 453	MHz
Circuit Current	ldd	$P_{in} = -16 \text{ dBm}, \text{ V}_{AGC} = 2.5 \text{ V}$	_	35	45	mA
Power Gain	GP	$P_{in} = -16 \text{ dBm}, \text{ V}_{AGC} = 2.5 \text{ V}$	28	30	-	dB
Adjacent Channel Power Leakage 1	P <sub>adj1</sub>	$P_{out} = +12 \text{ dBm}, V_{AGC} = 2.5 \text{ V},$ $\Delta f = \pm 50 \text{ kHz}, 21 \text{ kHz Bandwidth}$	-	-60	-55	dBc
Adjacent Channel Power Leakage 2	Padj2	$P_{out} = +12 \text{ dBm}, V_{AGC} = 2.5 \text{ V},$ $\Delta f = \pm 100 \text{ kHz}, 21 \text{ kHz} Bandwidth$	-	-70	-65	dBc
Gain Control Range	GCR	$P_{in} = -16 \text{ dBm}, \text{ V}_{AGC} = 0.5 \text{ to } 2.5 \text{ V}$	37	42	-	dB
Gain Control Current	lage	V <sub>AGC</sub> = 0.5 to 2.5 V	_	250	500	μΑ

# **EVALUATION CIRCUIT**

f = 1 429 to 1 453 MHz, VDD1 = 3.0 V, VDD2 = 3.5 V



The application circuits and their parameters are for reference only and are not intended for use in actual design-ins.



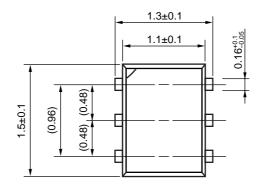
# ILLUSTRATION OF THE TEST CIRCUIT ASSEMBLED ON EVALUATION BOARD

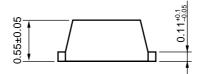
# USING THE NEC EVALUATION BOARD

Symbol	Values
C1, C3, C5	1 000 pF
C2	3 pF
C4	5 pF
C6	2 pF
L1	1.0 nH
L2	8.2 nH
L3	6.8 nH
R1	1 kΩ

# PACKAGE DIMENSIONS

# 6-PIN LEAD-LESS MINIMOLD (1511) (UNIT: mm)





Remark (): Reference value

#### **RECOMMENDED SOLDERING CONDITIONS**

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your nearby sales office.

Soldering Method	Soldering Conditions		Condition Symbol
Infrared Reflow	Peak temperature (package surface temperature) Time at peak temperature Time at temperature of 220°C or higher Preheating time at 120 to 180°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 60 seconds or less : 120±30 seconds : 3 times : 0.2%(Wt.) or below	IR260
VPS	Peak temperature (package surface temperature) Time at temperature of 200°C or higher Preheating time at 120 to 150°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 215°C or below : 25 to 40 seconds : 30 to 60 seconds : 3 times : 0.2%(Wt.) or below	VP215
Wave Soldering	Peak temperature (molten solder temperature) Time at peak temperature Preheating temperature (package surface temperature) Maximum number of flow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 120°C or below : 1 time : 0.2%(Wt.) or below	WS260
Partial Heating	Peak temperature (pin temperature) Soldering time (per side of device) Maximum chlorine content of rosin flux (% mass)	: 350°C or below : 3 seconds or less : 0.2%(Wt.) or below	HS350

Caution Do not use different soldering methods together (except for partial heating).

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Caution GaAs Products	The product contains gallium arsenide, GaAs. GaAs vapor and powder are hazardous to human health if inhaled or ingested.			
	Do not destroy or burn the product.			
	Do not cut or cleave off any part of the product.			
	Do not crush or chemically dissolve the product.			
	Do not put the product in the mouth.			
	Follow related laws and ordinances for disposal. The product should be excluded from general industrial waste or household garbage.			

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